Ellipsometric study of hydrous gold oxide layers and gold surfaces resulting from their electroreduction

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Abstract

The ellipsometric responses of hydrous gold oxide layers (HAuOLs) and electroreduced gold surfaces (EDAuEs) resulting from HAuOL electroreduction have been studied in the 400-700 nm spectral range. For HAuOL the values of *n* and *k* are in the $1.760 \le n \le 1.930$ and $0 \le k \le 0.24$ ranges respectively. These results are discussed in terms of possible H₂O-Au oxide molar ratios. For EDAuEs the values of $n(\lambda)$ are $k(\lambda)$ depend on the preparation conditions. These results are interpreted in terms of a composite EDAuE structure consisting of Au domains and solution-filled voids.

1. Introduction

The electrochemical roughening of several f.c.c. metals can be achieved in a reproducible way by using the procedure described in the literature [1, 2] which involves two stages: (i) the formation of a metal oxide layer by applying a periodic potential routine; (ii) the electroreduction of the oxide layer. By adjusting the different electrical parameters it is possible to obtain metal overlayers with appreciable roughness depending on the metal [3, 4].

Ellipsometric data of both hydrous Au oxide layers (HAuOLs), and Au overlayers (EDAuEs) resulting from the electroreduction of HAuOLs under different potential-controlled conditions are reported in this work. The HAuOL can be described as a quasi-homogeneous layer with a stoichiometry comprising definite H_2O-Au oxide molar ratios, whereas the EDAuE behaves as a material made of Au and solution-filled void domains.

2. Experimental details

A gold disc (Johnson Matthey Chem. Co.; Specpure quality; 0.64 cm² apparent area) working electrode, an Au foil auxiliary electrode and a hydrogen reference electrode in the cell solution ($0.5 \text{ M H}_2\text{SO}_4$) were assembled in a conventional cell for ellipsometric measurements. Potentials are referred to the reversible hydrogen electrode (RHE) scale. The electrolyte solution was prepared from H₂SO₄ Merck p.a. and Milli-Q* water.

The working electrode was first mirror polished with 0.3 and 0.05 μ m alumina, then rinsed several times with Milli-Q* water and finally immersed in the cell. The ellipsometer (Rudolph Research type 437002/200 E) was employed in the null mode, with the incident light beam at 69° and the azimuth angle (compensator) set at 135°. The 400–700 nm spectral range was covered using adequate filters.

The experimental procedure was as follows.

(i) The cyclovoltammogram of the working electrode in 0.5 M H₂SO₄ was attained between $E_{s,a} = 1.75$ V and $E_{s,c} = 0$ V at v = 0.1 V s⁻¹. This voltammogram was taken as the reference.

(ii) The ellipsometric parameters of the initial Au surface were obtained at 0 V.

(iii) Relatively thick HAuOLs were formed by applying a symmetric square-wave periodic potential at f = 5 kHz, between $E_u = 2.7 \text{ V}$ and $E_1 = 0.45 \text{ V}$ for $1 \text{ min} \le \tau \le 9 \text{ min}$; f, E_u, E_1 and τ are the frequency, the upper potential step, the lower potential step and the treatment time respectively [5].

(iv) The ellipsometric parameters of the HAuOL were measured at 1.5 V and at six wavelengths.

(v) The HAuOL was electroreduced at either $v = 0.1 \text{ V s}^{-1}$ or $v = 0.001 \text{ V s}^{-1}$, and the value of Q_{HAuOL} , the Au oxide charge, was calculated.

(vi) The EDAuE optical parameters were determined at 0 V and six wavelengths.

(vii) The voltammogram of the EDAuE were obtained as indicated in (i). The surface roughness of EDAuE was evaluated as the O-electrodesorption voltammetric charge ratio corresponding to the EDAuE and that of the initial gold surface of (i) [6].

3. Results

3.1. Determination of the optical parameters

Ellipsometric data for HAuOLs at 1.5 V and EDAuEs at 0 V were obtained at 405, 450, 492, 546, 580 and 671 nm. Measurements were made in a range of times in which the influence of the decay process [7] could be neglected. The average of two series of readings at all wavelengths was taken to compensate small shifts due to the time effect. For each wavelength λ and different film thicknesses d_{HAuOL} , the experimental amplitude ratio Ψ and the phase shift Δ were obtained. Theoretical Δ and Ψ values were calculated by means of a subroutine which finds the local minimum of a function of several variables [8]. The refractive index *n* and the absorption coefficient *k* were determined assuming a single isotropic and homogeneous film [9].

3.1.1. The hydrous gold oxide layers

Values of Δ and Ψ for HAuOLs at 1.5 V corresponding to different thicknesses d_{HAuOL} as well as those resulting from the fitting procedure are shown in Fig. 1. Depending on λ , values of *n* of between 1.760 and 1.930, and values of *k* of between 0.24 to 0, were found. The λ dependence of *n* and *k* are shown in Fig. 2 including error bars.

3.1.2. The electroreduced gold overlayers

Ellipsometric data for EDAuEs depend on whether the HAuOL electroreduction was made at $v = 0.1 \text{ V s}^{-1}$ or $v = 0.001 \text{ V s}^{-1}$. This reflects in the value of the film thicknesses d_{EDAuE} . The dependences of *n* and *k* on λ are displayed in Fig. 3. Only for $\lambda = 405 \text{ nm}$ does the value of *n* approach that of bulk Au [10, 11]. For EDAuEs prepared at 0.001 and 0.1 V s⁻¹ the difference in *n* becomes greater as λ increases. On the contrary, the values of *k* for EDAuEs are lower than for bulk Au.



Fig. 1. Plots of Ψ vs. Δ for HAuOL at (a) $\lambda = 405$ nm and (b) $\lambda = 671$ nm: \times , experimental data; \oplus , calculated data. The numbers indicate the average d_{HAuOL} values in nanometres.



Fig. 2. Plots of k vs. λ and n vs. λ for HAuOL.



Fig. 3. Plots of *n* vs. λ and *k* vs. λ for polycrystalline Au (blank) (\blacksquare), and for EDAuE obtained at $v = 0.1 \text{ V s}^{-1}$ (\bullet) and $v = 0.001 \text{ V s}^{-1}$ (\blacktriangle): ..., data when the refractive index of the solution n_{sol} is 1.332.

The $d_{\rm EDAuE}$ vs. $d_{\rm HAuOL}$ plot (Fig. 4) shows that, for the same $d_{\rm HAuOL}$, the value of $d_{\rm EDAuE}$ resulting at 0.001 V s⁻¹ is greater than that resulting at 0.1 V s⁻¹.



Fig. 4. Plot of d_{EDAuE} vs. d_{HAuOL} for EDAuEs obtained at $v = 0.001 \text{ V s}^{-1}$ (\bigcirc) and $v = 0.1 \text{ V s}^{-1}$ (\bigcirc).

4. Discussion

4.1. The hydrous gold oxide layers

The values of n and k for the HAuOLs are lower than those reported for Au oxide layers grown at 1.5 V [12]. This suggests that the HAuOL contains a larger amount of water than that grown at 1.5 V. Therefore the n and k values for HAuOLs can be compared with those obtained through the effective medium theories [13-19] for an ideal mixture of Au₂O₃ and H₂O. This calculation shows an H₂O content in the HAuOL matrix in the 65-75% range. On the contrary the apparent density ρ and the H₂O content can be estimated from $Q_{\rm HAuOL}$, the voltammetric electroreduction charge and the molar volume V_{HAuOL} of HAuOL. The latter can be obtained from d_{HAuOL} . To estimate the apparent HAuOL density, it is assumed that the formation of HAuOL at 2.7 V produces Au(OH)₃, H₂O and residual O₂ trapped in the HAuOL. Thus for an average stoichiometry such as Au(OH)₃·O₂·8 H₂O the electroreduction reaction can be written as follows:

$$Au(OH)_3 \cdot O_2 \cdot 8 H_2O + 7e^- = Au + 7OH^- + 6H_2O$$
 (1)

Reaction (1) involves the transfer of seven F per mole of HAuOL. On the basis of these assumptions and the slope of the Q_{HAuOL} vs. V_{HAuOL} plots, the following upper and lower limiting density values were estimated: $\rho_{HAuOL} = 7.6 \text{ g cm}^3$ and $\rho_{HAuOL} = 4.6 \text{ g cm}^{-3}$. These values which are much smaller than the $\rho_{Au_2O_3}$ value of 11 g cm⁻³ [20] confirm that the H₂O content of HAuOL is in the 65–75% range. This result is consistent with the structure previously proposed for HAuOL [21].



Fig. 5. Plots of *n* vs. q_{Au} resulting from EMT (----), MGT 1 for Au dispersed in H₂O (----) and MGT 2 (----) for H₂O dispersed in an Au matrix ($\lambda = 671$ nm): •, experimental values obtained at v = 0.1 V s⁻¹; •, experimental values obtained at v = 0.001 V s⁻¹.

4.2. The electroreduced gold overlayers

According to the optical parameter the EDAuE can be described as a material made of bulk metal domains and solution-filled voids. For a structure of this type the effective-medium theories [13-19] allow us to explain the different properties of EDAuEs. Correlations for nand k from Fig. 5 were obtained from the Bruggeman effective medium theory (EMT) [18] and the Maxwell Garnett theory (MGT) [16], the latter considering both possibilities, namely Au clusters dispersed in H₂O (MGT1), and H₂O dispersed in the Au matrix (MGT2). For this purpose, different values of the volume fractions q_{Au} of Au and the volume fractions $q_{H_{2O}}$ of solution were considered. At each λ the value of q_{Au} was estimated from the intersection of the experimental n and k values (Fig. 5, dotted lines) at each sweep rate v, and the curves predicted by the different theories.

The d_{HAuOL} vs. d_{EDAuE} plots (Fig. 4) indicate the development of a rough Au structure for $d_{\text{HAuOL}} \ge 60 \text{ nm}$. Also, the roughness development through HAuOL electroreduction increases as v is decreased. The optical indices of EDAuE obtained at $v = 0.1 \text{ Vs}^{-1}$ and $v = 0.001 \text{ V s}^{-1}$ indicate that the water content changes from 65 to 75%. The EDAuE obtained at 0.1 V s^{-1} becomes rougher although more dense than that prepared at 0.001 V s^{-1} . These results are consistent with the brush-like structure of EDAuE recently derived from scanning tunnelling microscope imaging [21, 22].

5. Conclusions

(1) Considering HAuOL as an isotropic film, λ -dependent optical constants which are in the $1.760 \le n \le 1.930$ and $0 \le k \le 0.24$ ranges are obtained.

(2) The HAuOL can be described as a material made of the oxide and water with a H_2O -to-Au oxide volume ratio ranging between 65 and 75%.

(3) The optical indices of EDAuE depend on both λ and the HAuOL electroreduction rate. Higher Au contents and lower EDAuE thicknesses are obtained as v is changed from 0.1 to 0.001 V s⁻¹.

(4) The EDAuE consist of a brush-like structure in which the density of bristles increases as v is increased.

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References

 A. C. Chialvo, W. E. Triaca and A. J. Arvia, J. Electroanal. Chem., 146 (1983) 93.

- 2 A. Visintin, J. C. Canullo, W. E. Triaca and A. J. Arvia, J. Electroanal. Chem., 221 (1987) 239.
- 3 W. E. Triaca, T. Kessler, J. C. Canullo and A. J. Arvia, J. Electrochem. Soc., 134 (1987) 1165.
- 4 A. M. Castro Luna, M. C. Giordano and A. J. Arvia, J. Electroanal. Chem., 259 (1989) 173.
- 5 A. C. Chialvo, W. E. Triaca and A. J. Arvia, J. Electroanal. Chem., 171 (1984) 303.
- 6 M. E. Vela, R. C. Salvarezza and A. J. Arvia, J. Electrochim. Acta, 35 (1990) 117.
- 7 A. J. Arvia, R. C. Salvarezza and W. E. Triaca, *Electrochim. Acta*, 34 (1989) 1057.
- 8 D. den Engelsen, J. Opt. Soc. Am., 61 (1971) 460.
- 9 J. O. Zerbino, W. J. Plieth and G. Kossmehl, J. Appl. Electrochem., 21 (1991) 935.
- 10 P. B. Johnson and R. W. Christy, Phys. Rev. B, 6 (1972) 4370.
- 11 M. A. Ordal, L. L. Long, R. J. Bell, S. E. Bell, R. R. Bell, R. W. Alexander and C. A. Ward, *Appl. Opt.*, 22 (1983) 1099.
- 12 D. M. Kolb and J. D. E. McIntyre, Surf. Sci., 28 (1971) 321.
- 13 D. E. Aspnes and J. B. Theeten, Phys. Rev. B, 20 (1979) 3292.
- 14 C. A. Fenstermaker and F. L. McCrackin, Surf. Sci., 16 (1969) 85.
- 15 D. E. Aspnes, in E. D. Palik (ed.), Handbook of Optical Constants of Solids, Academic Press, New York, Chapter 5, p. 89.
- 16 J. C. Maxwell Garnett, Philos. Trans. R. Soc. A, London, 203 (1904) 385; 205 (1906) 237.
- 17 J. I. Gittleman and B. Abeles, Phys. Rev. B, 15 (1977) 3273.
- 18 D. A. G. Bruggeman, Ann. Phys. (Leipzig), 24 (1935) 636.
- 19 C. G. Granqvist and O. Hunderi, Phys. Rev. B., 18 (1978) 2897.
- 20 M. M. Lohrengel and J. W. Schultze, *Electrochim. Acta*, 21 (1976) 957.
- 21 M. M. Gómez, L. Vázquez, R. C. Salvarezza and A. J. Arvia, J. Electroanal. Chem., 317 (1991) 125.
- 22 A. J. Arvia, R. C. Salvarezza and J. M. Vara, *Electrochim. Acta*, 37 (1992) 2155.